Notice of References Cited	Application/Control No. 10/659,880	Applicant(s)/Patent Under Reexamination VERDUN ET AL.		
	Examiner	Art Unit	Page 1 of 1	
	ALVIN H. TAN	2173		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,366,307	04-2008	Yanz et al.	381/60
	В	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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